

OSG60R150x_Datasheet



Enhancement Mode N-Channel Power MOSFET

Features

- ◆ Low $R_{DS(on)}$ & FOM
- ◆ Extremely low switching loss
- ◆ Excellent stability and uniformity
- ◆ Easy to drive

Applications

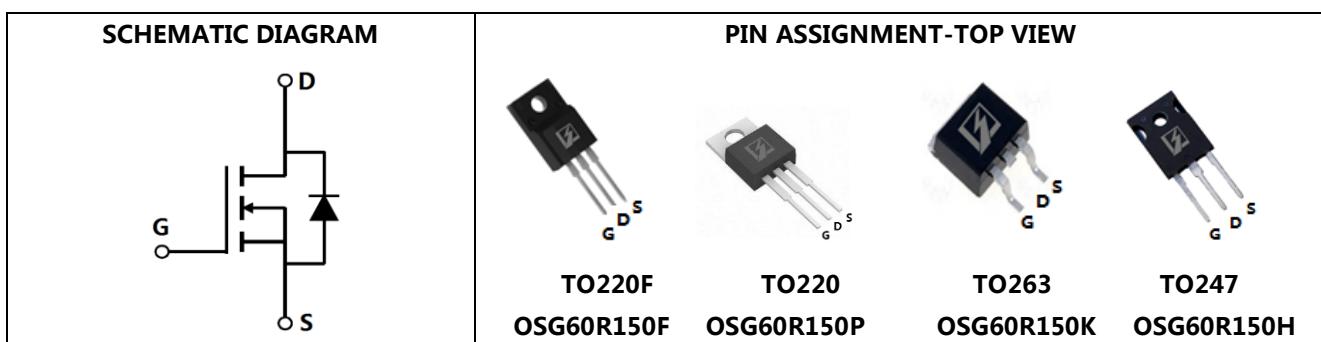
- ◆ Lighting
- ◆ Hard switching PWM
- ◆ Server power supply
- ◆ Charger

■ General Description

OSG60R150x use advanced GreenMOS™ technology to provide low $R_{DS(ON)}$, low gate charge, fast switching and excellent avalanche characteristics. This device is suitable for active power factor correction and switching mode power supply applications.

◆ V_{DS} , min@T _{jmax}	650 V
◆ I_D , pulse	69 A
◆ $R_{DS(ON)}$, max @ V _{GS} =10 V	150 mΩ
◆ Q_g	23 nC

■ Schematic and Package Information



■ Absolute Maximum Ratings at T_j=25°C unless otherwise noted

Parameter	Symbol	Value	Unit
Drain source voltage	V _{DS}	600	V
Gate source voltage	V _{GS}	±30	V
Continuous drain current ¹⁾	I _D	23	A
Continuous drain current ¹⁾ T _j =100 °C		14.5	
Pulsed drain current ²⁾	I _D , pulse	69	A
Power dissipation ³⁾ for TO220, TO263, TO247	P _D	151	W
Power dissipation ³⁾ for TO220F		34	
Single pulsed avalanche energy ⁵⁾	E _{AS}	600	mJ
MOSFET dv/dt ruggedness, V _{DS} =0...480 V	dv/dt	50	V/ns
Reverse diode dv/dt, V _{DS} =0...480 V, I _{SD} ≤I _D	dv/dt	15	V/ns
Operation and storage temperature	T _{stg} , T _j	-55 to 150	°C

■ Thermal Characteristics

Parameter	Symbol	Value		Unit
		TO220/TO263/TO247	TO220F	
Thermal resistance, junction-case	R _{θJC}	0.82	3.67	°C/W
Thermal resistance, junction-ambient ⁴⁾	R _{θJA}	62	62.5	°C/W

■ Electrical Characteristics at T_j=25 °C unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-source breakdown voltage	BV _{DSS}	600			V	V _{GS} =0 V, I _D =250 μA
		650	716			V _{GS} =0 V, I _D =250 μA T _j =150 °C
Gate threshold voltage	V _{GS(th)}	2.0		4.0	V	V _{DS} =V _{GS} , I _D =250 μA
Drain-source on-state resistance	R _{DS(ON)}		0.12	0.15	Ω	V _{GS} =10 V, I _D =10 A
			0.29			V _{GS} =10 V, I _D =10 A, T _j =150 °C
Gate-source leakage current	I _{GSS}			100	nA	V _{GS} =30 V
				-100		V _{GS} =-30 V
Drain-source leakage current	I _{DSS}			1	μA	V _{DS} =600 V, V _{GS} =0 V

■ Dynamic Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Input capacitance	C _{iss}		1356		pF	V _{GS} =0 V, V _{DS} =50 V, f=1 MHz
Output capacitance	C _{oss}		155		pF	
Reverse transfer capacitance	C _{rss}		2		pF	
Turn-on delay time	t _{d(on)}		38.2		ns	V _{GS} =10 V, V _{DS} =400 V, R _G =25 Ω, I _D =10 A
Rise time	t _r		25.2		ns	
Turn-off delay time	t _{d(off)}		79.2		ns	
Fall time	t _f		31.5		ns	

■ Gate Charge Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Total gate charge	Q_g		23		nC	$I_D=10\text{ A}$, $V_{DS}=400\text{ V}$, $V_{GS}=10\text{ V}$
Gate-source charge	Q_{gs}		6.0		nC	
Gate-drain charge	Q_{gd}		8.3		nC	
Gate plateau voltage	$V_{plateau}$		5.6		V	

■ Body Diode Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Diode forward current	I_S			23	A	$V_{GS} < V_{th}$
Pulsed source current	I_{SP}			69		
Diode forward voltage	V_{SD}			1.4	V	$I_S=23\text{ A}, V_{GS}=0\text{ V}$
Reverse recovery time	t_{rr}		258.1		ns	$V_R=400\text{ V}, I_S=10\text{ A}$, $di/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge	Q_{rr}		2.8		μC	
Peak reverse recovery current	I_{rrm}		19		A	

■ Note

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) P_d is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_a=25\text{ }^\circ\text{C}$.
- 5) $V_{DD}=100\text{ V}$, $R_G=25\text{ }\Omega$, $L=10.8\text{ mH}$, starting $T_j=25\text{ }^\circ\text{C}$.



■ Electrical Characteristics Diagrams

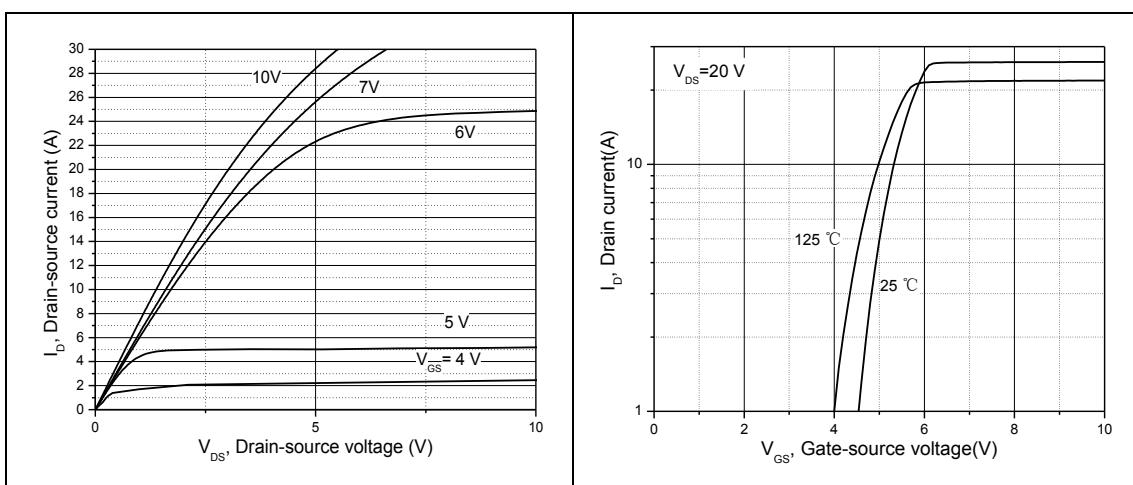


Figure 1, Typ. output characteristics

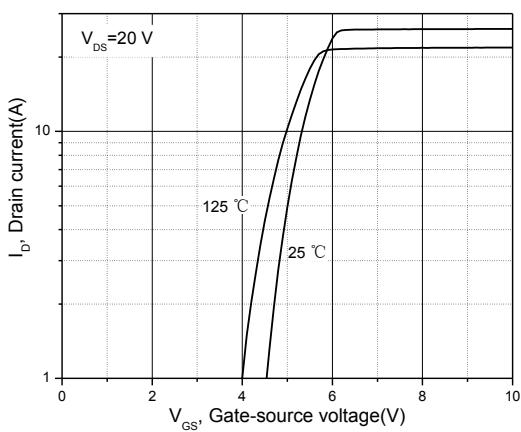


Figure 2, Typ. transfer characteristics

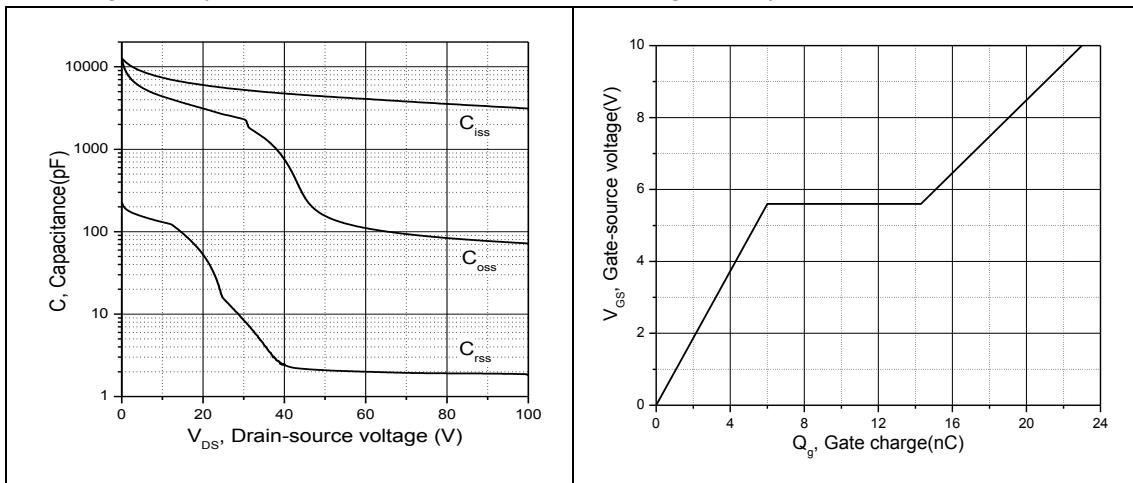


Figure 3, Typ. capacitances

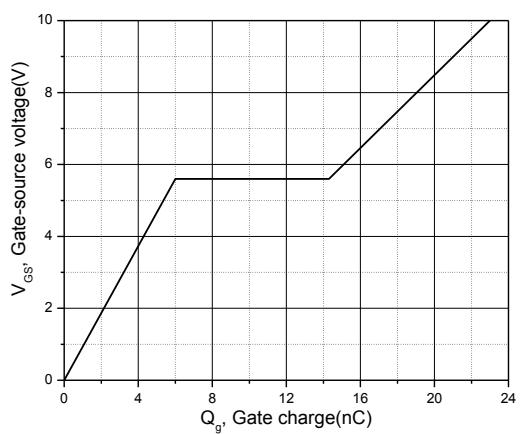


Figure 4, Typ. gate charge

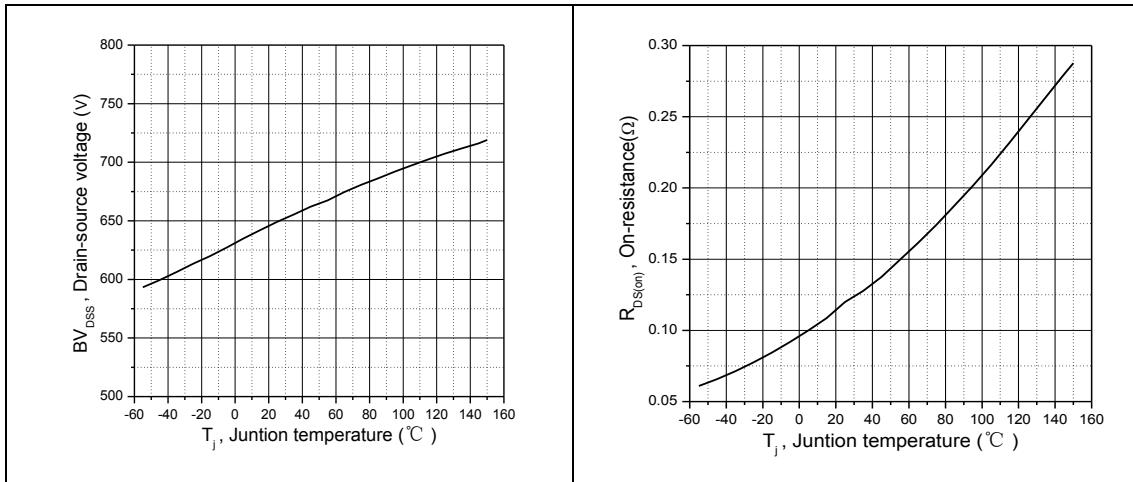


Figure 5, Drain-source breakdown voltage

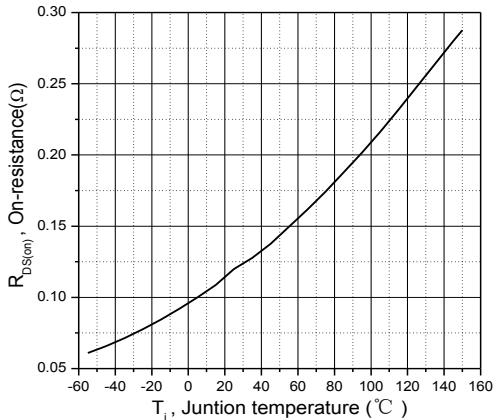


Figure 6, Drain-source on-state resistance

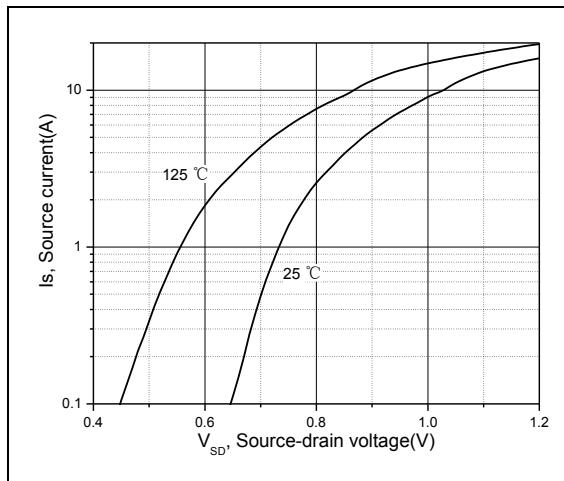


Figure 7, Forward characteristic of body diode

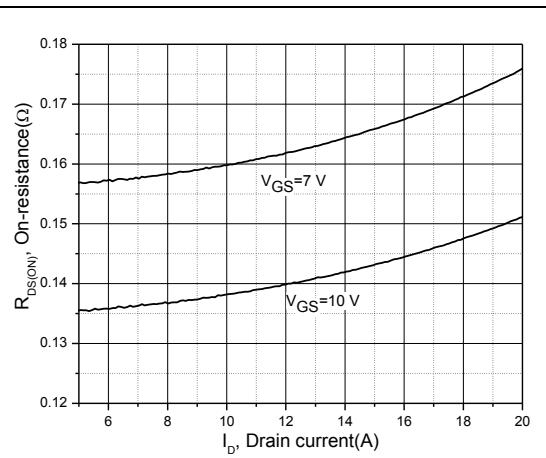


Figure 8, Drain-source on-state resistance

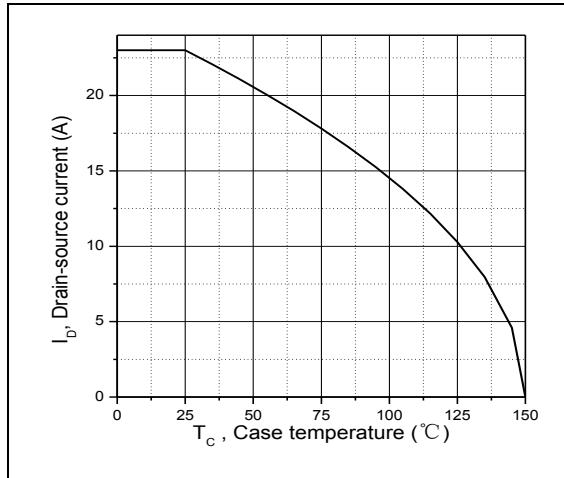
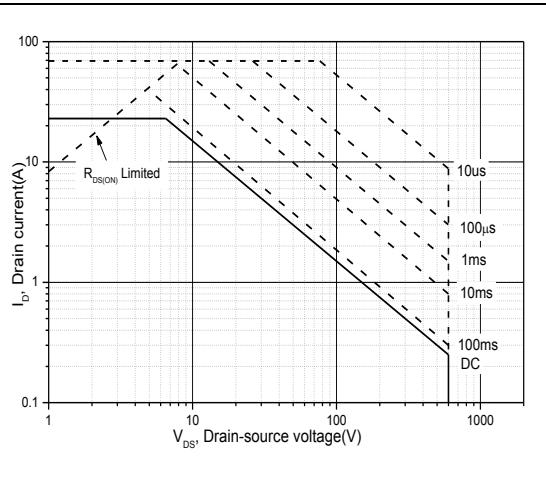
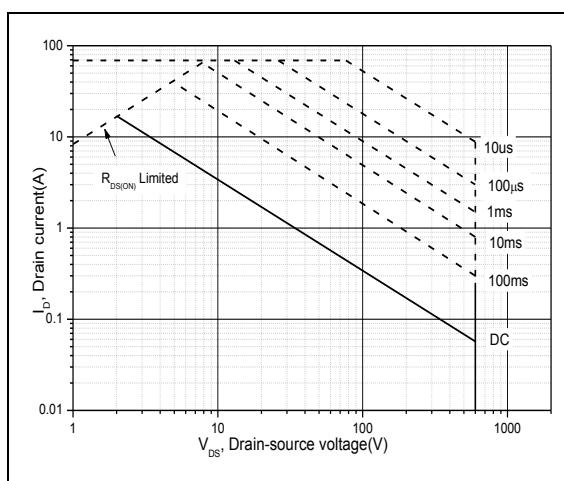


Figure 9, Drain current

Figure 10, Safe operation area for
TO220/TO263/TO247 $T_C = 25^\circ\text{C}$ Figure 11, Safe operation area for TO220F
 $T_C = 25^\circ\text{C}$



■ Test circuits and waveforms

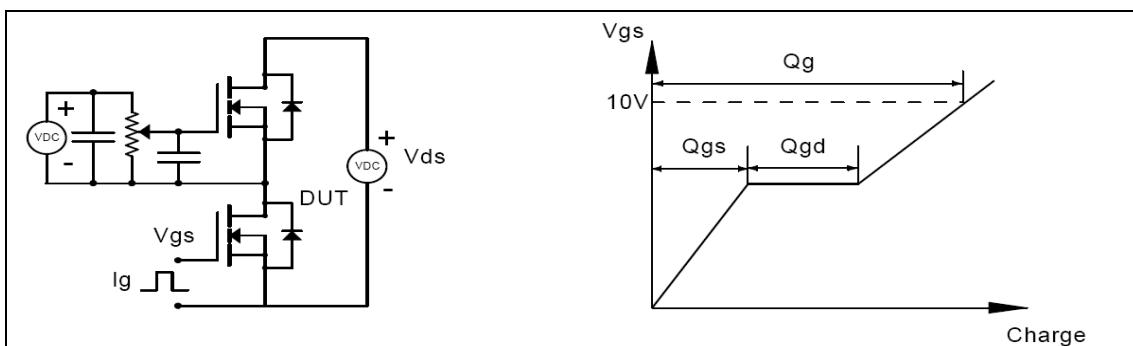


Figure 1, Gate charge test circuit & waveform

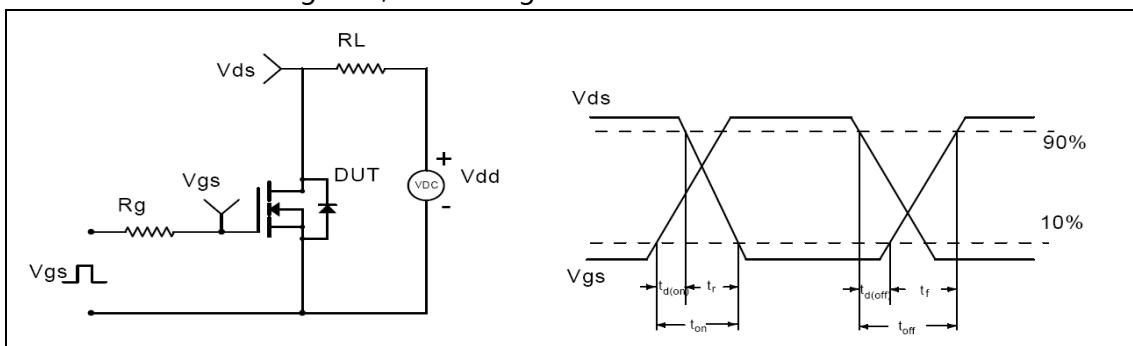


Figure 2, Switching time test circuit & waveforms

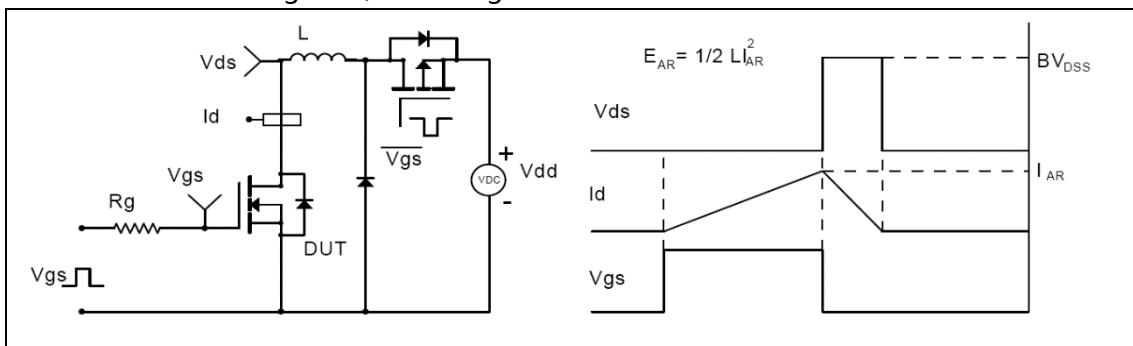


Figure 3, Unclamped inductive switching (UIS) test circuit & waveforms

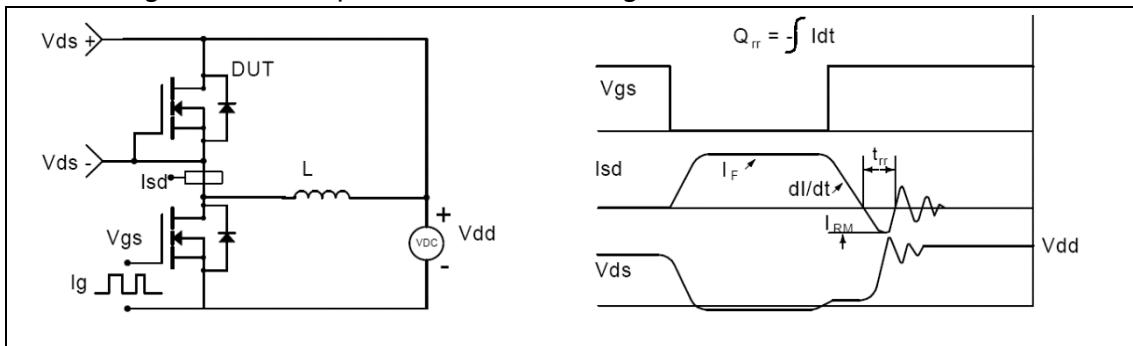
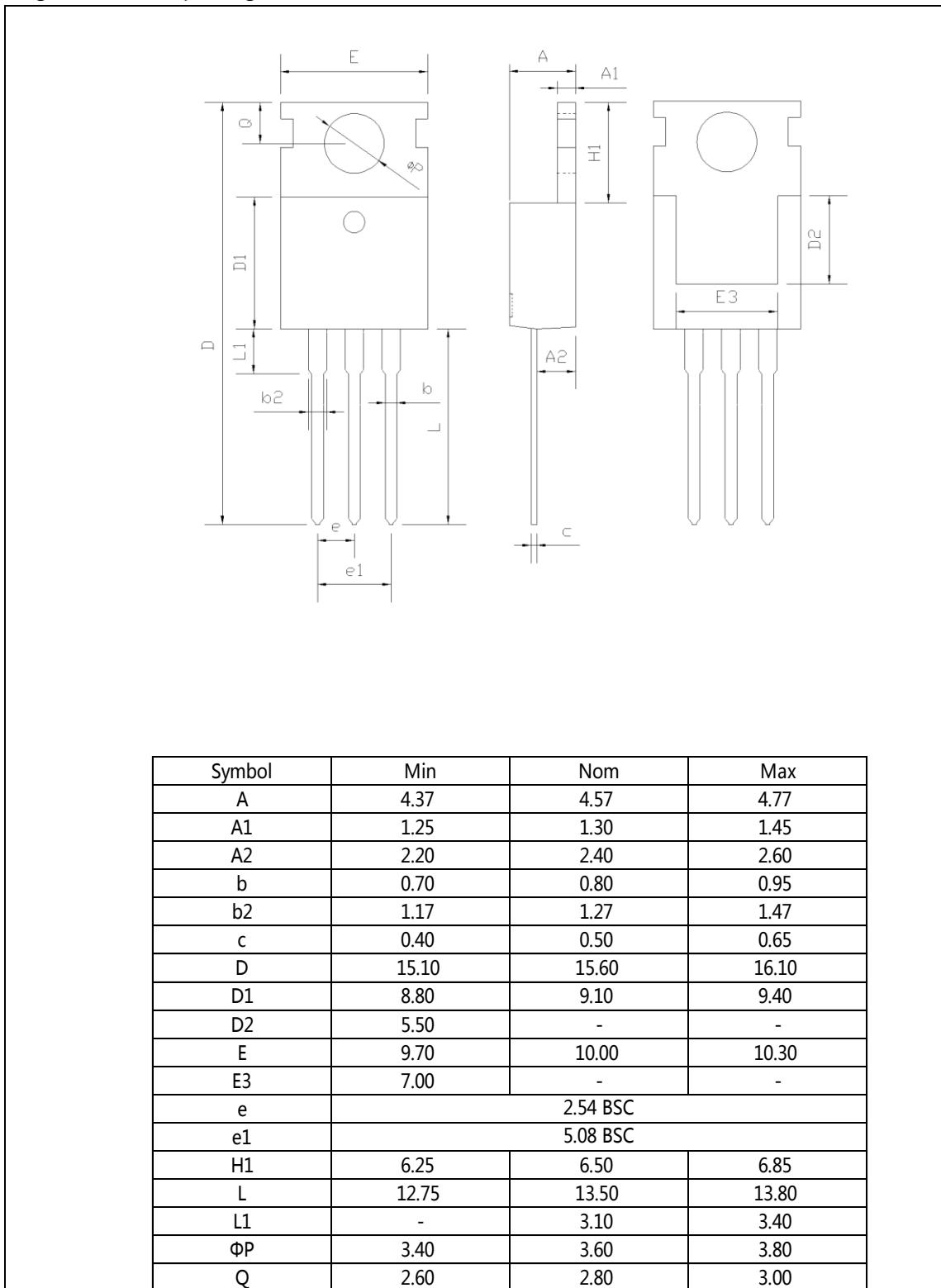


Figure 4, Diode reverse recovery test circuit & waveforms

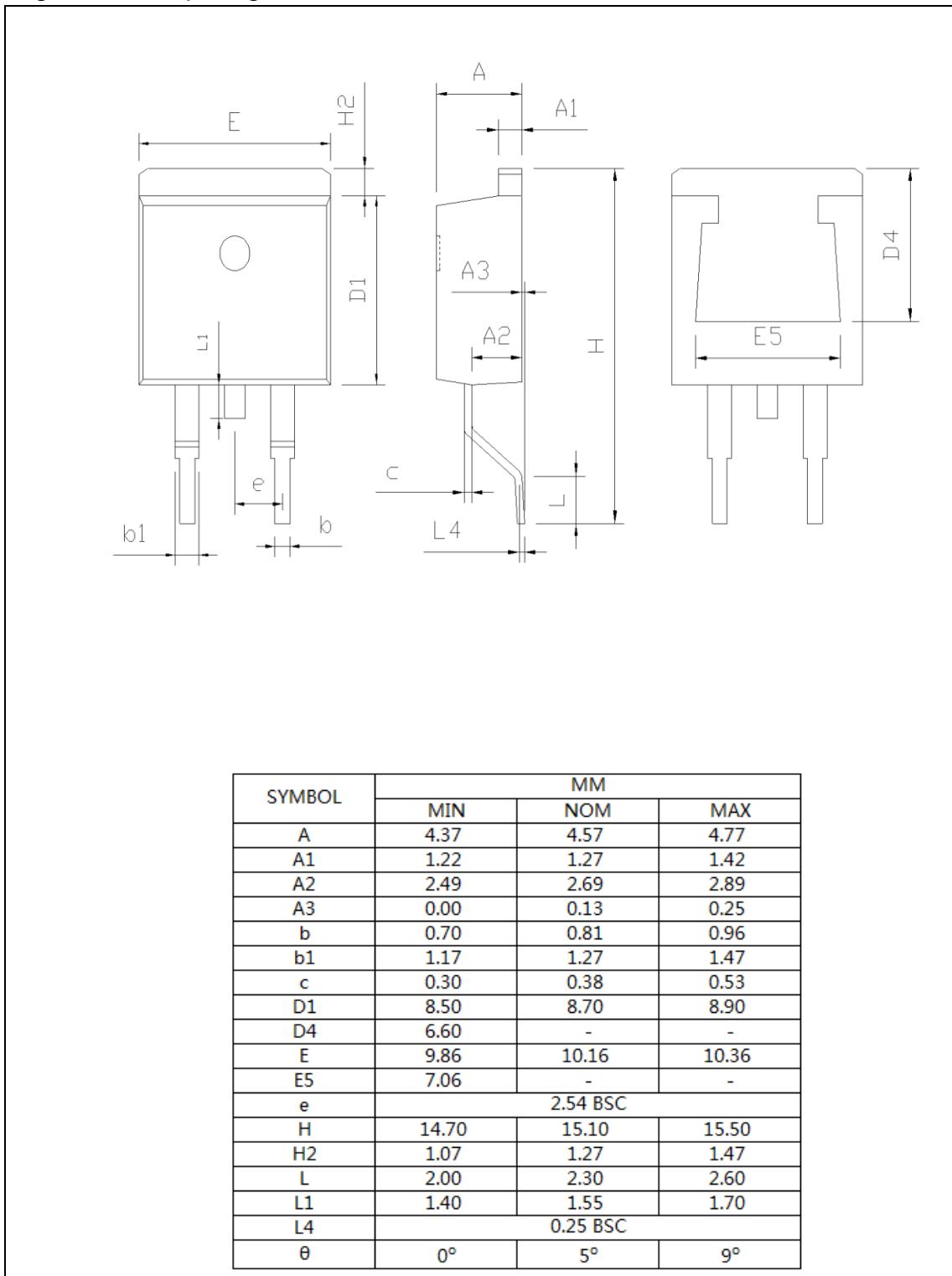
■ Package Information

Figure2, TO220 package outline dimension



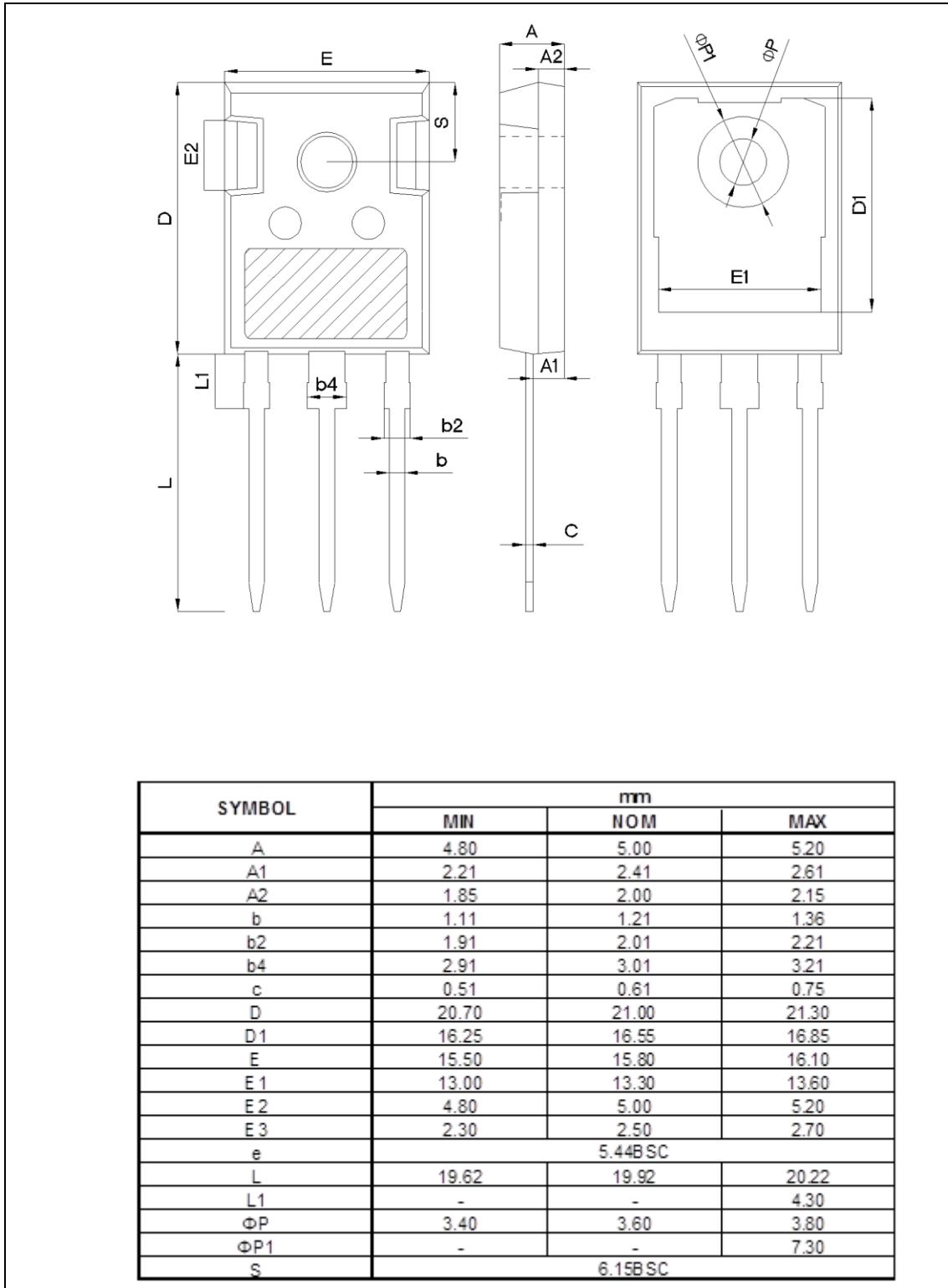
■ Package Information

Figure3, TO263 package outline dimension



■ Package Information

Figure4, TO247 package outline dimension



■ Ordering Information

Package	Units/Tube	Tubes/Inner Box	Units/Inner Box	Inner Box/Carton Box	Units/Carton Box
TO220F	50	20	1000	6	6000
TO220	50	20	1000	6	6000
TO263	50	20	1000	6	6000
TO247	30	11	330	6	1980

■ Product Information

Product	Package	Pb Free	RoHS	Halogen Free
OSG60R150F	TO220F	yes	yes	no
OSG60R150FF	TO220F	yes	yes	yes
OSG60R150P	TO220	yes	yes	no
OSG60R150PF	TO220	yes	yes	yes
OSG60R150K	TO263	yes	yes	no
OSG60R150KF	TO263	yes	yes	yes
OSG60R150H	TO247	yes	yes	no
OSG60R150HF	TO247	yes	yes	yes